

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient AF	t ≤ 10s	Б	70	90	°C/W			
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State	κ <sub>θJA</sub>	100	125	°C/W			
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	63	80	°C/W			

## Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V		-30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V				-1	
			TJ=52°C			-5	μA
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V				±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=-250 \mu A$		-1.5	-2	-2.5	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V		-30			А
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.3A			39	48	mΩ
			T <sub>J</sub> =125°C		55	68	
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A			61	78	mΩ
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-4.3A			11		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =-1A,V <sub>GS</sub> =0V			-0.78	-1	V
I <sub>s</sub>	Maximum Body-Diode Continuous Current					-2	А
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz			668	830	рF
C <sub>oss</sub>	Output Capacitance				126		рF
C <sub>rss</sub>	Reverse Transfer Capacitance				92		рF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			6	9	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge (10V)	- -V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-4.3A -			12.7	16	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge (4.5V)				6.4		nC
Q <sub>gs</sub>	Gate Source Charge				2		nC
$Q_{gd}$	Gate Drain Charge				4		nC
t <sub>D(on)</sub>	Turn-On DelayTime	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =3.5Ω, R <sub>GEN</sub> =3Ω			7.7		ns
t <sub>r</sub>	Turn-On Rise Time				6.8		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				20		ns
t <sub>f</sub>	Turn-Off Fall Time				10		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-4.3A, dI/dt=100A	/μs		22	30	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-4.3A, dl/dt=100A	/μs		15		nC

A: The value of R  $_{\theta,JA}$  is measured with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T  $_A$  =25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\rm \theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\rm \theta JL}$  and lead to ambient.

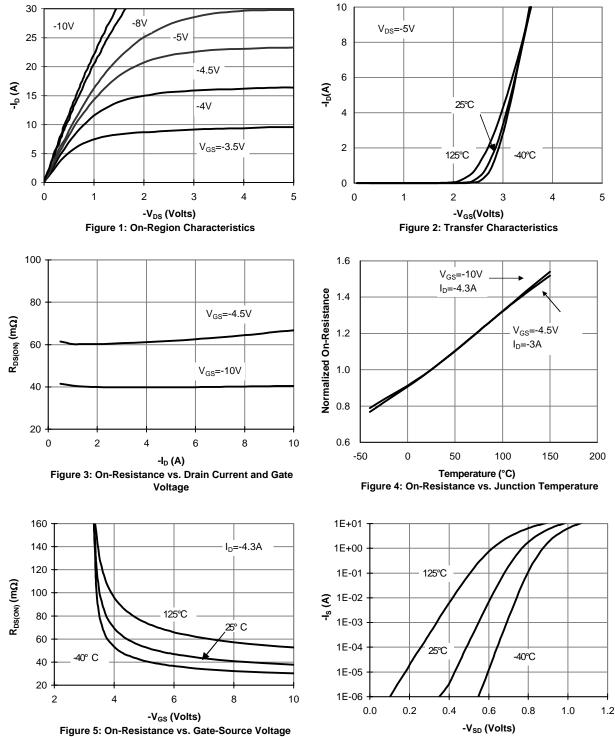
D. The static characteristics in Figures 1 to 6 are obtained using < 300 $\mu$ s pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  ${}^{2}$  FR-4 board with 2oz. Copper, in a still air environment with T A=25°C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t  $\leq$  10s thermal resistance rating.

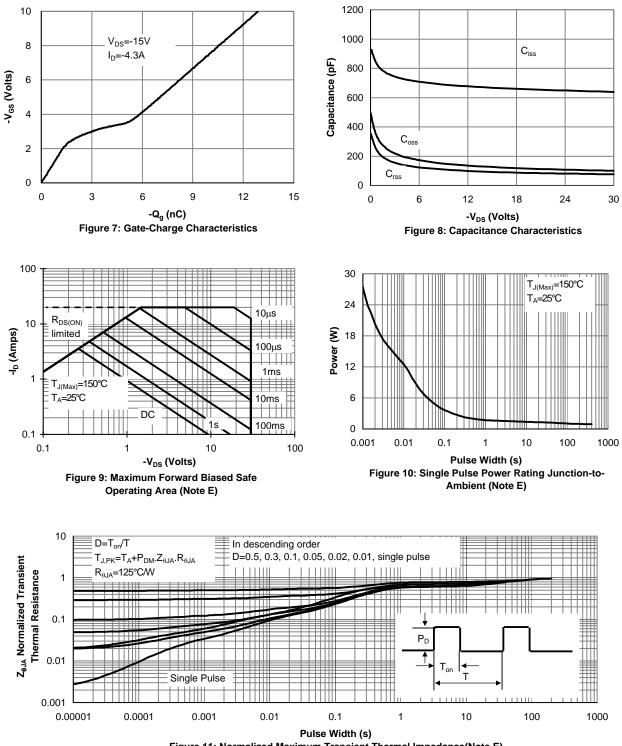
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## **TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

Figure 6: Body-Diode Characteristics



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